

1. Global joint venture starts operations as WeEn Semiconductors

Dear customer,

As from November 9th, 2015 NXP Semiconductors N.V. and Beijing JianGuang Asset Management Co. Ltd established Bipolar Power joint venture (JV), **WeEn Semiconductors**, which will be used in future Bipolar Power documents together with new contact details.

In this document where the previous NXP references remain, please use the new links as shown below.

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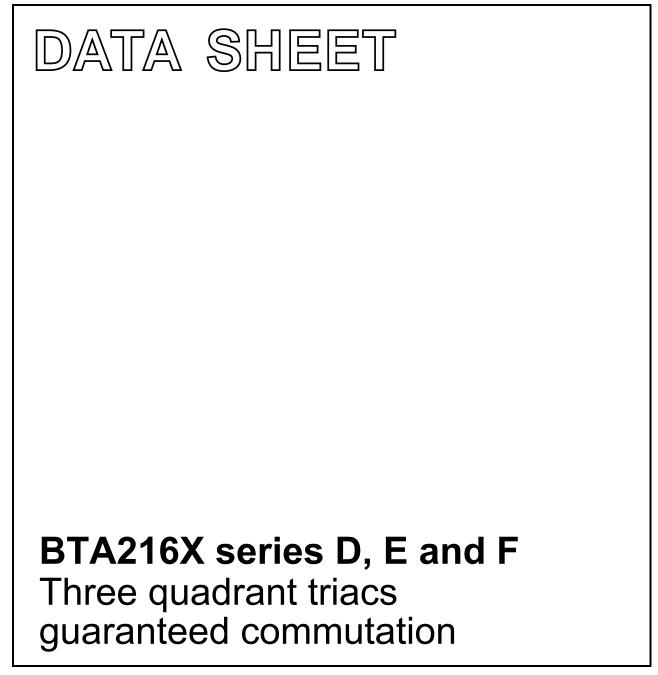
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Thank you for your cooperation and understanding,

WeEn Semiconductors



DISCRETE SEMICONDUCTORS



Product specification

April 2002



MAX.

600D

600E

600F

600

16

140

UNIT

٧

А

А

Three quadrant triacs guaranteed commutation

BTA216X series D, E and F

GENERAL DESCRIPTION

Passivated guaranteed commutation triacs in a full pack, plastic envelope intended for use in motor control circuits or with other highly inductive loads. These devices balance the requirements of commutation performance and gate sensitivity. The "sensitive gate" E series and "logic level" D series are intended for interfacing with low power drivers, including micro controllers.

DESCRIPTION

PINNING - SOT186A

main terminal 1

main terminal 2

PIN

1

2

3

case

QUICK REFERENCE DATA

current

PARAMETER

SYMBOL

V_{DRM}

T(RMS)

PIN CONFIGURATION

ITSM

SYMBOL

Repetitive peak off-state voltages

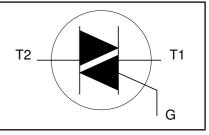
Non-repetitive peak on-state

RMS on-state current

BTA216X-

BTA216X-

BTA216X-



LIMITING VALUES

isolated

gate

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
	Repetitive peak off-state voltages		-	600 ¹	V
I _{T(RMS)} I _{TSM}	RMS on-state current Non-repetitive peak on-state current	full sine wave; $T_{hs} \le 38 \degree C$ full sine wave; $T_j = 25 \degree C$ prior to	-	16	A
l ² t dl _T /dt	I ² t for fusing Repetitive rate of rise of on-state current after	surge t = 20 ms t = 16.7 ms t = 10 ms $I_{TM} = 20 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu \text{s}$	- -	140 150 98 100	A A A²s A/µs
$\begin{matrix} I_{GM} \\ P_{GM} \\ P_{G(AV)} \end{matrix}$	triggering Peak gate current Peak gate power Average gate power	over any 20 ms period	- - -	2 5 0.5	A W W
T _{stg} T _j	Storage temperature Operating junction temperature		-40 -	150 125	ů Ĵ

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 $A/\mu s$.

Three quadrant triacs guaranteed commutation

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ISOLATION LIMITING VALUE & CHARACTERISTIC

 $T_{hs} = 25$ °C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{isol}	R.M.S. isolation voltage from all three terminals to external heatsink	f = 50-60 Hz; sinusoidal waveform; R.H. ≤ 65% ; clean and dustfree	-	-	2500	V
C _{isol}	Capacitance from T2 to external heatsink	f = 1 MHz	-	10	-	pF

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R _{th j-hs} R _{th j-a}	Thermal resistance junction to heatsink Thermal resistance junction to ambient	full or half cycle with heatsink compound without heatsink compound in free air	- - -	- - 55	4.0 5.5 -	K/W K/W K/W

STATIC CHARACTERISTICS

$T_i = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.		MAX.		UNIT
		BTA216X-		D	E	F	
I _{GT}	Gate trigger current ²	$V_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}$		_			
		T2+ G+ T2+ G-	-	5 5 5	10 10	25 25	mA mA
		T2-G-	-	5	10	25 25	mA
IL.	Latching current	$V_{D} = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$					
		T2+ G+ T2+ G-	-	15 25	25 30	30 40	mA mA
		T2- G-	-	25	30	40	mA
I _H	Holding current	V _D = 12 V; I _{GT} = 0.1 A	-	15	25	30	mA
			D, E, F				
V _T	On-state voltage	I _T = 20 A	-		1.5		V
V _{GT}	Gate trigger voltage	$V_{\rm D} = 12 \text{ V}; I_{\rm T} = 0.1 \text{ A}$	-		1.5		V
		$V_{D}^{r} = 400 \text{ V}; I_{T} = 0.1 \text{ A};$ $T_{i} = 125 \text{ °C}$	0.25		-		v
I _D	Off-state leakage current	$V_{\rm D} = V_{\rm DRM(max)}; T_{\rm j} = 125 ^{\circ}{\rm C}$	-	0.5		mA	

² Device does not trigger in the T2-, G+ quadrant.

Three quadrant triacs guaranteed commutation

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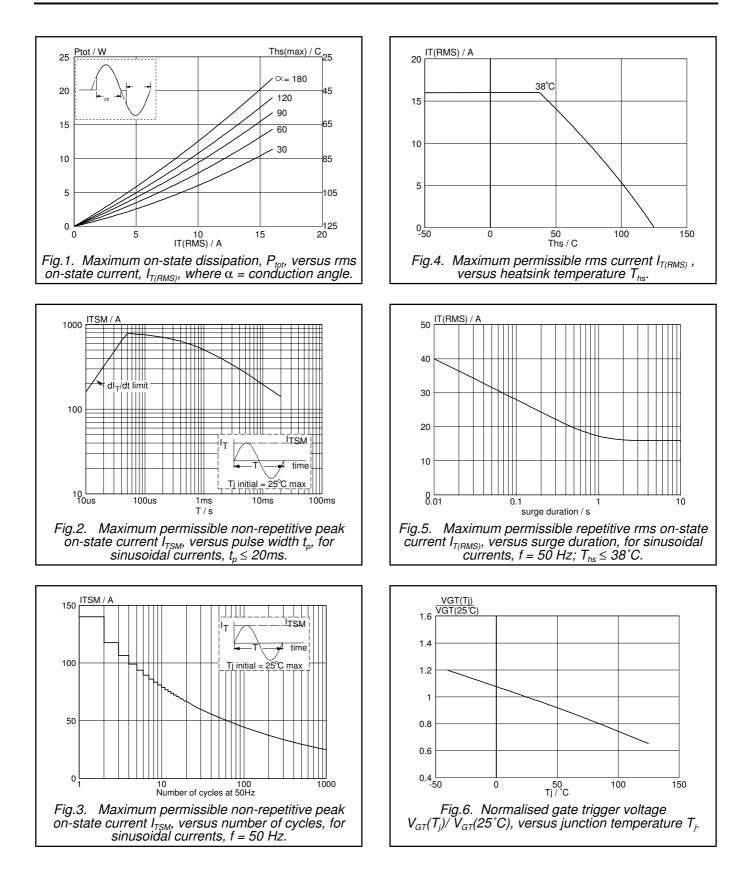
DYNAMIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS		MIN.		MAX.	UNIT
		BTA216X-	D	E	F		
dV _D /dt	Critical rate of rise of off-state voltage	$V_{DM} = 67\% V_{DRM(max)};$ $T_j = 110$ °C; exponential waveform; gate open circuit	30	60	70	-	V/µs
dl _{com} /dt	Critical rate of change of commutating current	$V_{DM} = 400 \text{ V}; \text{ T}_{j} = 125 \text{ °C};$ $I_{T(RMS)} = 16 \text{ A};$ $dV_{com}/dt = 10V/\mu \text{s}; \text{ gate}$ open circuit	2.5	6.2	18	-	A/ms
dl _{com} /dt	Critical rate of change of commutating current	$\label{eq:V_DM} \begin{array}{l} V_{\text{DM}} = 400 \ \text{V}; \ T_j = 125 \ ^\circ\text{C}; \\ I_{\text{T(RMS)}} = 16 \ \text{A}; \\ dV_{\text{com}}/dt = 0.1 \ \text{V/}\mu\text{s}; \ \text{gate} \\ \text{open circuit} \end{array}$	12	20	50	-	A/ms

Three quadrant triacs guaranteed commutation

BTA216X series D, E and F



BTA216X series D, E and F

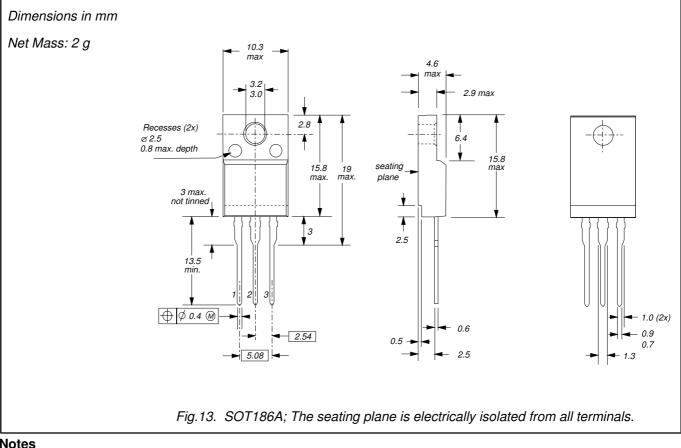
Three quadrant triacs guaranteed commutation

IT / A IGT(Tj) IGT(25℃) 50 Tj = 125 C Tj = 25 C 3 — T2+ G+ — T2+ Gtyp ma - T2- G-40 2.5 Vo = 1.195 V Rs = 0.018 Ohms 2 30 1.5 20 1 10 0.5 0 L 0 0 1.5 VT / V 150 0.5 2 2.5 3 -50 0 тј/℃ 100 1 Fig.7. Normalised gate trigger current $I_{GT}(T_j)/I_{GT}(25^{\circ}C)$, versus junction temperature T_{j} . Fig.10. Typical and maximum on-state characteristic. IL(Tj) IL(25°C) 10 Zth j-hs (K/W) with heatsink compound 3 without heatsink compound 25 1 2 0.1 1.5 → ^tp → 1 0.01 0.5 0.001 – 10us 0 -50 0.1ms 10ms 0.1s 1s 10s 50 Tj /℃ 100 1ms 0 150 tp/s Normalised latching current $I_L(T_i)/I_L(25^{\circ}C)$, Fig.8. Fig.11. Transient thermal impedance $Z_{th j-mb}$, versus versus junction temperature T_{i} pulse width t_{p} dlcom/dt (A/ms) IH(Tj) 100 3 IH(25°C F TYPE E TYPE D TYPE 2.5 2 10 1.5 1 0.5 1 0 -50 50 Tj /℃ 20 40 60 100 120 140 0 100 150 80 Tj/°C Fig.9. Normalised holding current $I_H(T_i)/I_H(25^{\circ}C)$, versus junction temperature T_j . Fig.12. Minimum, critical rate of change of commutating current dI_{com}/dt versus junction temperature, $dV_{com}/dt = 10V/\mu s$.

BTA216X series D, E and F

Three quadrant triacs guaranteed commutation

MECHANICAL DATA



Notes 1. Refer to mounting instructions for F-pack envelopes. 2. Epoxy meets UL94 V0 at 1/8".

Legal information

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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Contact information

For additional information please visit: http://www.nxp.com For sales offices addresses send e-mail to: salesaddresses@nxp.com

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